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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Complete if Known		
			Application Number	10/541,411-Conf. #6372	
			Filing Date	July 5, 2005	
			First Named Inventor	Takeharu ETOH	
			Art Unit	2878	
			Examiner Name	S. B. Allen Le	
Sheet	1	of	1	Attorney Docket Number	0020-5396PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
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/QL/	CA	"A CCD Image Sensor of 1M frames/s for Continuous Image Capturing of 103 Frames" Digest of Technical Papers, 2002 IEEE International Solid-State Circuits Conference, 2002, Vol. 45, p. 46 to 47; and Takeharu ETOH and four others.	x
/QL/	CB	"An In-situ Storage Image Sensor of 1M frames/s with Slanted Linear CCD Storage" Journal of the Institute of Image Information and Television Engineers, the Institute of Image Information and Television Engineers, 2002, Vol. 56, No. 3, p.483 to 486.	x

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Examiner Signature	/Que Tan Le/	Date Considered	10/10/2007
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/QL/	AA	US-2002/0060741-A1	03-23-2002	NIKON CORP.	
	AB	US-5,907,767-A	05-25-1999	NEC CORP.	
/QL/	AC	US-2003/0089908-A1	05-15-2003	MUTOH et al.	

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/QL/	BA	JP-9-82932-A	03-28-1997			ABS
	BB	JP-59-108465-A	06-22-1984			ABS
	BC	JP-2001-345441-A	12-14-2001			ABS
	BD	JP-2001-210812-A	08-03-2001			ABS
	BE	JP-2000-324400-A	11-24-2000			ABS
	BF	KR-97-18448-A	04-30-1997			
	BG	EP-1 278 246-A1	01-22-2003			
	BH	WO-01/73849-A1	10-04-2001			
	BI	JP-2002-135659-A	05-10-2002			ABS
/QL/	BJ	JP-9-331052-A	12-22-1997			ABS

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